IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Pa	atent A	pplica	ation of:	
Kenzo	FUKU	/OSH	II et al.	·
Application No.: Unassigned				Group Art Unit: Unassigned
Filed: I	March	31, 20	004	Examiner: Unassigned
For:	SOLID	-STA	TE IMAGING DEVICE AND MA	NUFACTURING METHOD THEREFOR
			INFORMATION DISCLOS	SURE STATEMENT
Assista Washir			ioner for Patents 20231	
Sir:				
provide the sub	ed certa oject U.	ain inf S. pa	ormation which the Examiner m	ovisions of 37 CFR §1.56, there is hereby ay consider material to the examination of that the Examiner make this information of the subject application.
	1.	Encl	osures accompanying this Infor	mation Disclosure Statement are:
	1c. 1d.		application or a PCT Internation English language translation (deach non-English language put Explanations of Relevancy of F	complete or relevant portion(s)) attached to
	2. 🛚			a concise explanation of what is presently each non-English language publication is
	2a.	\boxtimes	enclosed "English-language ve indicates the degree of relevar 609, Minimum Requirements for	s 2a, 2b, 2c and/or 2d) sh language publications were cited on the ersion of the search report or action which nce found by the foreign office". (See MPEP or an Information Disclosure Statement, Part televance, pp. 600-100 to 600-101, Rev. 1,
	2b.		set forth in the application.	

Attorney Docket No. 1186.1034

2c. 🔲	satisfied because an English language translation (complete or relevant
	portion(s)) is attached to each non-English language publication.
2d. 🔲	enclosed as Attachment 1(e), hereto.

3. No admission is made that the information cited in this Statement is, or is considered to be, material to patentability nor a representation that a search has been made (other than search report(s) from a counterpart foreign application or a PCT International Search Report, if submitted herewith). 37 CFR §§1.97(g) and (h).

By:

Respectfully submitted,

STAAS & HALSEY LLP

Dated: March 31, 2004

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Registration No. 25,908

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FORM PTO-	1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			I I			APPLICATION NO. Unassigned			
PATENT AND TRADEMARK OFFIC					FIRST NAMED INVENTOR						
LIST OF DEFENCES CITED BY ADDITIONAL Kenzo FUKUYOSHI et al.											
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.